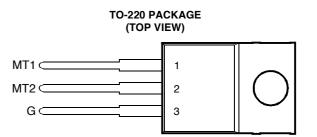
# BOURNS®



- 8 A RMS
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max I<sub>GT</sub> of 50 mA (Quadrants 1 3)



This series is currently available, but not recommended for new designs.

Pin 2 is in electrical contact with the mounting base.

#### absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING			VALUE	UNIT
	TIC226D		400	
Repetitive peak off-state voltage (see Note 1)	TIC226M	V	600	v
	TIC226S	V <sub>DRM</sub>	700	v
	TIC226N		800	
Full-cycle RMS on-state current at (or below) 85°C case temperature (see Note 2)			r(RMS) 8	
Peak on-state surge current full-sine-wave at (or below) 25°C case temperature (see Note 3)			70	А
Peak gate current			±1	А
Peak gate power dissipation at (or below) 85°C case temperature (pulse width $\leq$ 200 $\mu$ s)			2.2	W
Average gate power dissipation at (or below) 85°C case temperature (see Note 4)			0.9	W
Operating case temperature range			-40 to +110	°C
Storage temperature range			-40 to +125	°C
Lead temperature 1.6 mm from case for 10 seconds			230	°C

NOTES: 1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.

 This value applies for 50-Hz full-sine-wave operation with resistive load. Above 85°C derate linearly to 110°C case temperature at the rate of 320 mA/°C.

3. This value applies for one 50-Hz full-sine-wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.

4. This value applies for a maximum averaging time of 20 ms.

#### electrical characteristics at 25°C case temperature (unless otherwise noted )

PARAMETER		TEST CONDITIONS			MIN	ТҮР	MAX	UNIT
I <sub>DRM</sub>	Repetitive peak off-state current	$V_D = rated V_{DRM}$	$I_{G} = 0$	T <sub>C</sub> = 110°C			±2	mA
I <sub>GT</sub>		V <sub>supply</sub> = +12 V†	R <sub>L</sub> = 10 Ω	t <sub>p(g)</sub> > 20 μs		6	50	mA
	Gate trigger	$V_{supply} = +12 V^{\dagger}$	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-12	-50	
	current	$V_{supply} = -12 V^{\dagger}$	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-10	-50	
		$V_{supply} = -12 V^{\dagger}$	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		25		
V <sub>GT</sub>		V <sub>supply</sub> = +12 V†	R <sub>L</sub> = 10 Ω	t <sub>p(g)</sub> > 20 μs		0.7	2	v
	Gate trigger	$V_{supply} = +12 V^{\dagger}$	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-0.8	-2	
	voltage	$V_{supply} = -12 V^{\dagger}$	$R_L = 10 \Omega$	t <sub>p(g)</sub> > 20 μs		-0.8	-2	
		$V_{supply} = -12 V^{\dagger}$	$R_L = 10 \ \Omega$	t <sub>p(g)</sub> > 20 μs		0.9	2	
V <sub>T</sub>	On-state voltage	$I_T = \pm 12 \text{ A}$	l <sub>G</sub> = 50 mA	(see Note 5)		±1.5	±2.1	V

† All voltages are with respect to Main Terminal 1.

# PRODUCT INFORMATION

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#### electrical characteristics at 25°C case temperature (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS			MIN	ТҮР	MAX	UNIT
I <sub>H</sub>	Holding current	$V_{supply} = +12 V^{\dagger}$ $V_{supply} = -12 V^{\dagger}$	I <sub>G</sub> = 0 I <sub>G</sub> = 0	Init' I <sub>TM</sub> = 100 mA Init' I <sub>TM</sub> = -100 mA		10 -6	30 -30	mA
IL	Latching current	V <sub>supply</sub> = +12 V† V <sub>supply</sub> = -12 V†	(see Note 6)				50 -50	mA
dv/dt	Critical rate of rise of off-state voltage	$V_{DRM}$ = Rated $V_{DRM}$	I <sub>G</sub> = 0	T <sub>C</sub> = 110°C		±100		V/µs
dv/dt <sub>(c)</sub>	Critical rise of commu- tation voltage	$V_{DRM}$ = Rated $V_{DRM}$	$I_{\text{TRM}} = \pm 12 \text{ A}$	T <sub>C</sub> = 85°C (see figure 7)	±5			V/µs

† All voltages are with respect to Main Terminal 1.

NOTES: 5. This parameter must be measured using pulse techniques,  $t_p = \le 1$  ms, duty cycle  $\le 2$  %. Voltage-sensing contacts separate from the current carrying contacts are located within 3.2 mm from the device body.

6. The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics:  $R_G = 100 \Omega$ ,  $t_{p(g)} = 20 \mu s$ ,  $t_r = \le 15 ns$ , f = 1 kHz.

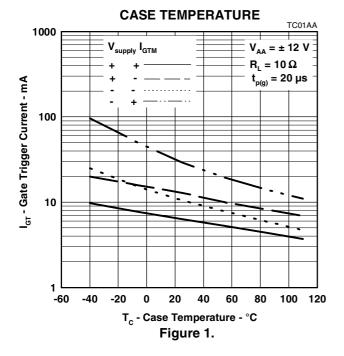
#### thermal characteristics

PARAMETER		MIN	ТҮР	MAX	UNIT
$R_{\theta JC}$	Junction to case thermal resistance			1.8	°C/W
$R_{\theta JA}$	Junction to free air thermal resistance			62.5	°C/W

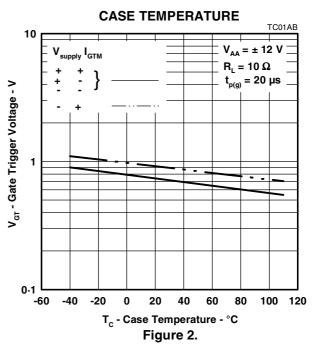
## **TYPICAL CHARACTERISTICS**

# GATE TRIGGER CURRENT

vs

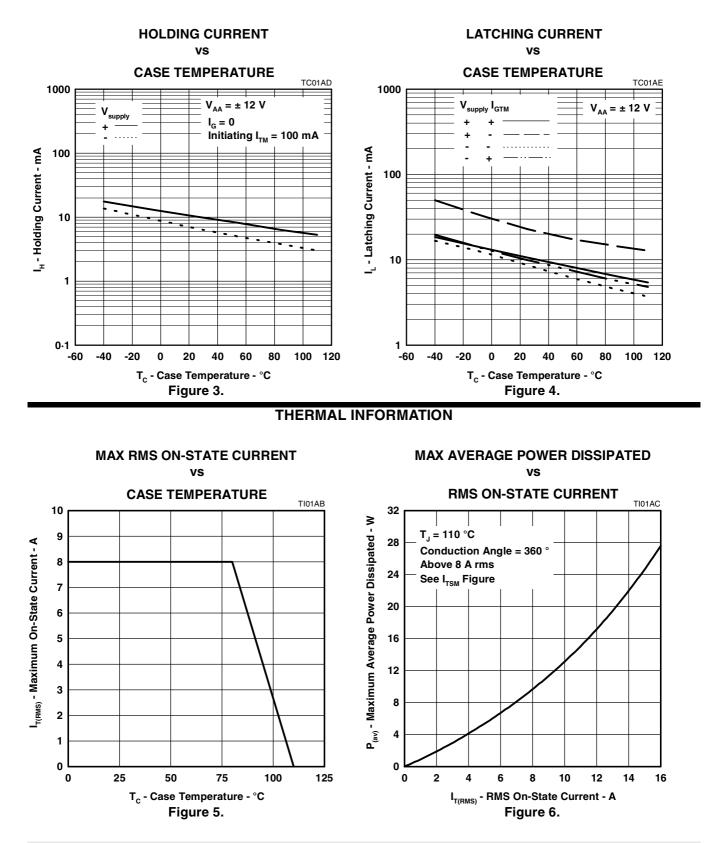


# GATE TRIGGER VOLTAGE



PRODUCT INFORMATION

## TYPICAL CHARACTERISTICS



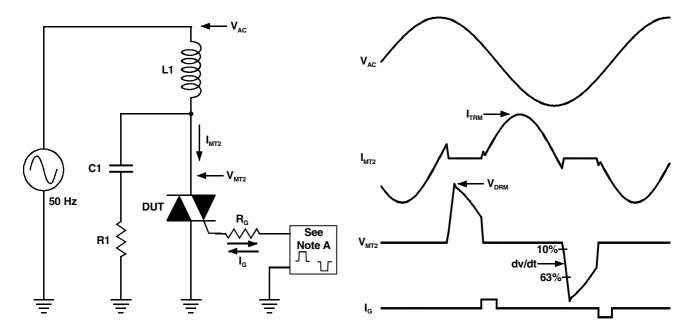
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#### PARAMETER MEASUREMENT INFORMATION



NOTE A: The gate-current pulse is furnished by a trigger circuit which presents essentially an open circuit between pulses. The pulse is timed so that the off-state-voltage duration is approximately 800 µs.

PMC2AA



